

DATA SHEET

SURFACE MOUNT MULTILAYER CERAMIC CAPACITORS

General purpose & High capacitance Class 2, X5R

100~pF to $220~\mu F$ RoHS compliant & Halogen free



YAGEO Phícomp



SCOPE

This specification describes X5R series chip capacitors with leadfree terminations.

<u>APPLICATIONS</u>

PCs, Hard disk, Game PCs Power supplies **DVD** players Mobile phones Data processing

FEATURES

Supplied in tape on reel Nickel-barrier end termination RoHS compliant Halogen free compliant

ORDERING INFORMATION-GLOBAL PART NUMBER, PHYCOMP CTC & 12NC

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value.

YAGEO BRAND ordering code

GLOBAL PART NUMBER (PREFERRED)

CC	<u>xxxx</u>	<u>x</u>	<u>x</u>	X5R	<u>x</u>	BB	XXX
	(1)	(2)	(3)		(4)		(5)

(I) SIZE - INCH BASED (METRIC)

0201 (0603)

0402 (1005)

0603 (1608)

0805 (2012)

1206 (3216)

1210 (3225)

(2) TOLERANCE

 $K = \pm 10\%$

 $M = \pm 20\%$

(3) PACKING STYLE

R = Paper/PE taping reel; Reel 7 inch

K = Blister taping reel; Reel 7 inch

P = Paper/PE taping reel; Reel 13 inch

F = Blister taping reel; Reel 13 inch

C = Bulk case

(4) RATED VOLTAGE

4 = 4 V

5 = 6.3 V

6 = 10 V

7 = 16 V

8 = 25 V

9 = 50 V

(5) CAPACITANCE VALUE

2 significant digits+number of zeros

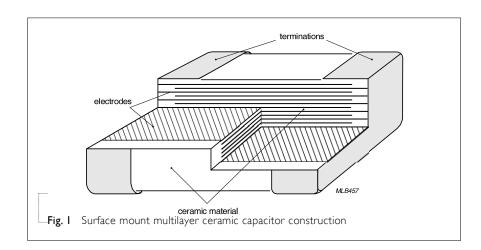
The 3rd digit signifies the multiplying factor, and letter R is decimal point

Example: $103 = 10 \times 10^3 = 10,000 \text{ pF} = 10 \text{ nF}$

CONSTRUCTION

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (NiSn). The terminations are lead-free. A cross section of the structure is shown in Fig. I.

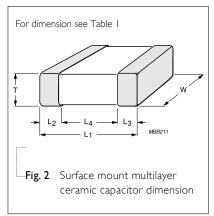


DIMENSION

Table I For outlines see fig. 2

TYPE	L _I (mm)	W (mm)	T (MM)	L ₂ / L ₃	3 (mm)	L ₄ (mm)	DIMENSION CODE
				min.	max.	min.	CODE
	0.6 ±0.03	0.3 ±0.03	0.3 ±0.03	0.1	0.2	0.2	ВА
0201	0.6 ± 0.05	0.3 ± 0.05	0.3 ± 0.05	0.1	0.2	0.2	BB
0201	0.6 ± 0.09	0.3 ± 0.09	0.3 ± 0.09	0.1	0.25	0.2	BC
	0.6 ±0.15	0.3 ±0.15	0.3 ±0.15	0.1	0.25	0.2	BD
	1.0 ±0.05	0.5 ±0.05	0.5 ±0.05	0.15	0.35	0.4	CA
0402	1.0 ±0.10	0.5 ±0.10	0.5 ± 0.10	0.15	0.35	0.4	СВ
0702	1.0 ± 0.15	0.5 ±0.15	0.5 ±0.15	0.15	0.35	0.4	CC
	1.0 ±0.20	0.5 ±0.20	0.5 ±0.20	0.15	0.35	0.4	CD
	1.6 ±0.10	0.8 ±0.10	0.8 ± 0.10	0.2	0.6	0.4	DA
0603	1.6 ±0.15	0.8 ±0.15	0.8 ± 0.15	0.2	0.6	0.4	DB
	1.6 ±0.20	0.8 ±0.20	0.8 ±0.20	0.2	0.6	0.4	DC
0805	2.0 ± 0.20	1.25 ±0.20	0.85 ± 0.10	0.25	0.75	0.7	EA
0003	2.0 ±0.20	1.25 ±0.20	1.25 ±0.20	0.25	0.75	0.7	EB
	3.2 ±0.15	1.6 ±0.15	1.15 ±0.10	0.25	0.75	1.4	FA
1206	3.2 ± 0.30	1.6 ±0.20	1.25 ±0.20	0.25	0.75	1.4	FB
1200	3.2 ± 0.30	1.6 ±0.30	1.60 ± 0.20	0.25	0.80	1.4	FC
	3.2 ±0.30	1.6 ±0.30	1.60 ±0.30	0.30	0.90	1.4	FD
	3.2 ± 0.40	2.5 ±0.30	1.25 ±0.20	0.25	0.75	1.4	GA
1210	3.2 ± 0.40	2.5 ±0.30	1.90 ±0.20	0.25	0.75	1.4	GB
1210	3.2 ± 0.40	2.5 ±0.30	2.5 ± 0.20	0.25	0.75	1.0	GC
	3.2 ±0.40	2.5 ±0.30	2.5 ±0.30	0.25	0.75	1.0	GD

OUTLINES





CAPACITANCE RANGE & THICKNESS FOR X5R

Table 2 Sizes from 0201 to 0402

CAP.	0201						0402					
	4 V	6.3 V	10 V	16 V	25 V	50 V	4 V	6.3 V	10 V	16 V	25 V	50 V
100 pF		ВА	ВА	ВА	ВА	ВА						
150 pF		ВА	ВА	ВА	ВА	ВА						
220 pF		ВА	ВА	ВА	ВА	ВА						
330 pF		ВА	ВА	ВА	ВА	ВА						
470 pF		ВА	ВА	ВА	ВА	ВА						
680 pF		ВА	ВА	ВА	ВА	ВА						
I.O nF		ВА	ВА	ВА	ВА	ВА						
I.5 nF		ВА	ВА	ВА	ВА							
2.2 nF		ВА	ВА	ВА	ВА							
3.3 nF		ВА	ВА	BA	BA							
4.7 nF		ВА	ВА	ВА	ВА							
6.8 nF		ВА	ВА	ВА	BA							
10 nF		ВА	ВА	ВА	ВА							
15 nF		ВА	ВА	ВА								
22 nF		ВА	ВА	ВА	ВА			CA	CA	CA	CA	CA
33 nF		ВА	ВА	ВА				CA	CA	CA	CA	CA
47 nF		ВА	ВА	ВА				CA	CA	CA	CA	CA
68 nF		ВА	ВА	ВА				CA	CA	CA	CA	CA
100 nF		ВА	ВА	ВА	ВВ			CA	CA	CA	CA	CA
150 nF								CA	CA	CA	CA	CA
220 nF	ВА	ВА	ВА	ВА				CA	CA	CA	CA	CA
330 nF								CA	CA			
470 nF	ВА	ВА	ВА	ВА				CA	CA	СВ	СВ	СВ
680 nF								CA	CA			
Ι.Ο μF	BB	BB	ВВ					CA	CA	CA	CA	
2.2 µF	ВС	ВС	ВС					CA	CA	CC	CD	
4.7 µF	BD						CC	CC	CC	CC		
ΙΟ μΕ							CD	CD	CD			
22 µF							CD	CD				

NOTE

- I. Values in shaded cells indicate thickness class in mm
- 2. Capacitance value of non E-6 series is available on request

CAPACITANCE RANGE & THICKNESS FOR X5R

Table 3	Sizes from	0603 to	0805
---------	------------	---------	------

CAP.	0603	11 0003 to 1					0805					
	4V	6.3 V	10 V	16 V	25 V	50V	4V	6.3 V	10 V	16 V	25 V	50V
IO nF												
15 nF												
22 nF												
33 nF												
47nF												
68 nF												
100 nF												
150 nF												
220 nF		DA	DA	DA	DA	DA						
330 nF		DA	DA	DA	DA	DA						
470 nF		DA	DA	DA	DA	DA		EA EB	EA EB	EA EB	EB	EB
680 nF		DA	DA	DA	DA	DA		EA EB	EA EB	EA EB	EB	EB
1.0 μF		DA	DA	DA	DA	DA		EA EB	EA EB	EA EB	EB	EB
2.2 µF		DA	DA	DA	DB	DC		EA EB	EA EB	EA EB	EA EB	EB
4.7 µF		DA	DA	DB	DB			EA EB	EA EB	EB	EB	EB
10 μF		DB	DC	DC	DC			EA EB	EA EB	EB	EB	EB
22 µF		DC	DC					EB	EB	EB	EB	
47 µF	DC	DC						EB	EB			
Ι00 μF							EB	EB				

NOTE

- 1. Values in shaded cells indicate thickness class in mm
- 2. Capacitance value of non E-6 series is available on request

18

Surface Mount Multilayer Ceramic Capacitors | General Purpose & High Cap. | XSR |

1	Sizes from 1	206 to 1210)				1210				
CAP.	1206 4 V	6.3 V	10 V	16 V	25 V	50V	1210 6.3 V	10 V	16 V	25 V	50V
10 nF											
15 nF											
22 nF											
33 nF											
47nF											
68 nF											
100 nF											
150 nF											
220 nF											
330 nF											
470 nF											
680 nF											
Ι.0 μF		FA	FA	FA	FA	FC	GA	GA	GA	GA	GA
2.2 µF		FA	FA	FA	FA	FC	GB	GB	GB	GB	GB
4.7 µF		FC	FC	FC	FC	FC	GB	GB	GB	GB	GC
ΙΟ μF		FC	FC	FC	FC	FD	GB	GB	GB	GB	GC
22 µF		FC	FC	FC	FD		GC	GC	GC	GD	
47 µF		FC	FC	FD			GC	GC	GC		
100 μF		FD					GD	GD	GD		
220 µF	FD						GD				

NOTE

- 1. Values in shaded cells indicate thickness class in mm
- 2. Capacitance value of non E-6 series is available on request

THICKNESS CLASSES AND PACKING QUANTITY

Table 5

lable 3			Ø100 MM	/ 7 INCH	Ø330 MM	/ I3 INICH	
SIZE CODE	THICKNESS CLASSIFICATION	TAPE WIDTH – QUANTITY PER REEL	Paper	Blister	Paper	Blister	QUANTITY PER BULK CASE
0201	0.3 ±0.03 mm	8 mm	15,000		50,000		
0402	0.5 ±0.05 / 0.1 mm	8 mm	10,000		50,000		50,000
0102	0.5 ±0.15 / 0.2 mm	8 mm	10,000		40,000		
0603	0.8 ±0.1 mm	8 mm	4,000		15,000		15,000
	0.6 ±0.1 mm	8 mm	4,000		20,000		10,000
0805	0.85 ±0.1 mm	8 mm	4,000		15,000		8,000
	1.25 ±0.2 mm	8 mm		3,000		10,000	5,000
	0.6 ±0.1 mm	8 mm	4,000		20,000		
	0.85 ±0.1 mm	8 mm	4,000		15,000		
1206	1.00 / 1.15 ±0.1 mm	8 mm		3,000		10,000	
1200	1.25 ±0.2 mm	8 mm		3,000		10,000	
	1.6 ±0.15 mm	8 mm		2,500		10,000	
	1.6 ±0.2 mm	8 mm		2,000		8,000	
	0.6 / 0.7 ±0.1 mm	8 mm		4,000		15,000	
	0.85 ±0.1 mm	8 mm		4,000		10,000	
	1.15 ±0.1 mm	8 mm		3,000		10,000	
	1.15 ±0.15 mm	8 mm		3,000		10,000	
	1.25 ±0.2 mm	8 mm		3,000			
1210	1.5 ±0.1 mm	8 mm		2,000			
	1.6 / 1.9 ±0.2 mm	8 mm		2,000			
	2.0 ±0.2 mm	8 mm		2,000 1,000			
	2.5 ±0.2 mm	8 mm		1,000 500			

ELECTRICAL CHARACTERISTICS

X5R DIELECTRIC CAPACITORS; NISN TERMINATIONS

Unless otherwise specified, all tests and measurements shall be made under standard atmospheric conditions for testing as given in 5.3 of IEC 60068-1:

- Temperature: 15 °C to 35 °C - Relative humidity: 25% to 75% - Air pressure: 86 kPa to 106 kPa

Table 6

Before the measurements are made, the capacitor shall be stored at the measuring temperature for a time sufficient to allow the entire capacitor to reach this temperature.

The period as prescribed for recovery at the end of a test is normally sufficient for this purpose.

Capacitano	ce range					100 - [+- 220
	ce tolerance					•	to 220 μF and ±20%
	n factor (D.F.)					±10/0	and ±20/0
X5R	0201	0402	0603	0805	1206	1210	D.F.
≤ 6.3V	100pF to 10nF	22nF to 100nF	220nF to TuF	470nF to 680nF	luF to 10uF	luF to 10uF	≤ 5%
		120nF to 220nF				22uF	≤ 7%
	12nF to 1uF	330nF to 10uF	2.2uF to 47uF	luF to 100uF	22uF to 47uF	47uF to 220uF	≤ 10%
	2.2uF				100uF, 220uF		≤ 15%
	4.7uF	22uF					≤ 20%
IOV	100pF to 10nF	22nF to 100nF	220nF to 470nF	470nF to 680nF	luF to 4.7uF	luF to 4.7uF	≤ 5%
		120nF to 220nF	680nF	luF			≤ 7%
	12nF to 220nF, 1uF	330nF to 10uF	I uF to 22uF	2.2uF to 47uF	10uF to 47uF	10uF to 100uF	≤ 10%
	470nF						≤ 15%
	2.2uF						≤ 20%
16V	100pF to 10nF	22nF to 100nF	220nF to 470nF	470nF to 680nF	luF to 4.7uF	luF to 4.7uF	≤ 5%
		120nF to 220nF	680nF to luF	I uF to 2.2uF			≤ 7%
	I 2nF to 220nF	470nF to 4.7uF	2.2uF to 10uF	4.7uF to 22uF	10uF to 47uF	10uF to 100uF	≤ 10%
	470nF						≤ 20%
25V	100pF to 10nF	22nF		470nF to TuF	I uF to 2.2uF	IuF to 4.7uF	≤ 3.5%
		27nF to 100nF	220nF to 470nF	2.2uF	4.7uF	I OuF	≤ 5%
		120nF to 220nF	680nF to luF				≤ 7%
	22nF, 100nF	470nF to 2.2uF	2.2uF to 10uF	4.7uF to 22uF	10uF to 22uF	22uF	≤ 10%
50V	100pF to 1nF	22nF					≤ 3.5%
		27nF to 120nF					≤ 5%
		150nF to 220nF					≤ 7%
		470nF	220nF to 2.2uF	470nF to 10uF	luF to 10uF	luF to 10uF	≤ 10%
	resistance after I min	* *		ins≥ 10 GΩ or Ri	ns × Cr≥ 50/100/5	500* seconds which	ever is less
	capacitance change as a		erature				±15%
	ure characteristic/coeffi	cient):					
Operating	temperature range:					−55 °C t	to +85 °C

NOTE

* Rins \geq 10 G Ω or Rins \times Cr \geq 500 Ω .F:

0201 : 100pF to 47nF 0402 : 22nF to 470nF 0603 : 220nF to TuF

1206: IuF to 2.2uF, 4.7uF/6.3V to 10V1210 : IuF to 2.2uF, 4.7uF/6.3V to 16V

0805 : 470nF to 2.2uF, 4.7uF/6.3V to 10V

1206: 4.7uF/16V to 50V, 10uF to 47uF

* Rins × $Cr \ge 100\Omega$.F:

0201: 100nF to 470nF

0402 : I uF to 4.7uF

0603: 2.2uF to 4.7uF

1210: 4.7uF/25V to 50V, 10uF to 220uF

0805: 4.7 uF/16V to 50V, 10 uF to 22 uF/4V to 25V

* Rins × Cr \geq 50 Ω .F:

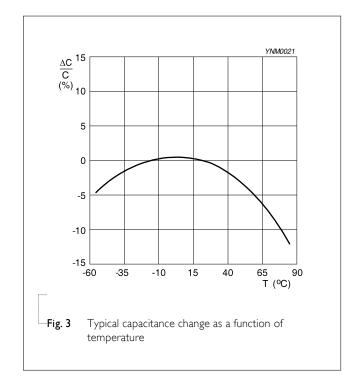
0201 : luF 0402 : IOuF 0603 : IOuF to 22uF

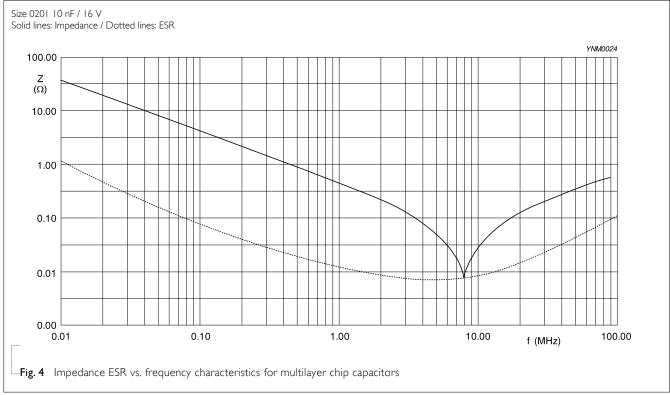
0805: 10uF/50V, 47uF to 100uF

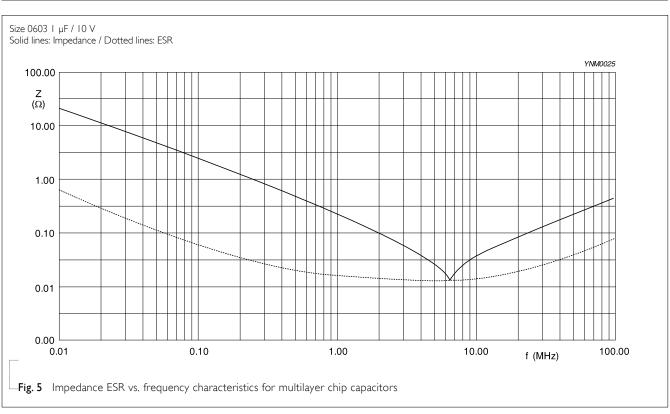
1206: 100uF, 220uF

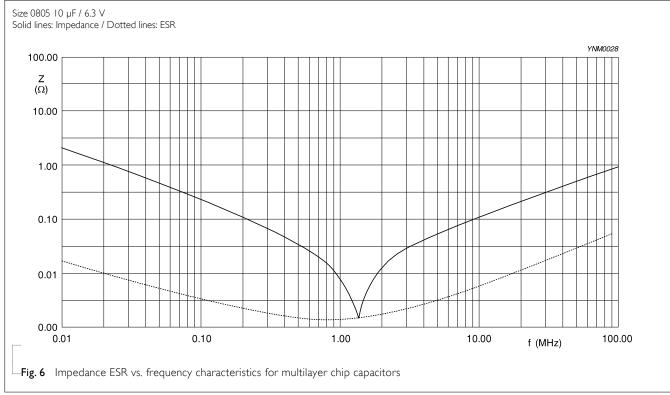
* Rins × Cr \geq 20 Ω ,F: 0201: 2.2uF to 4.7uF

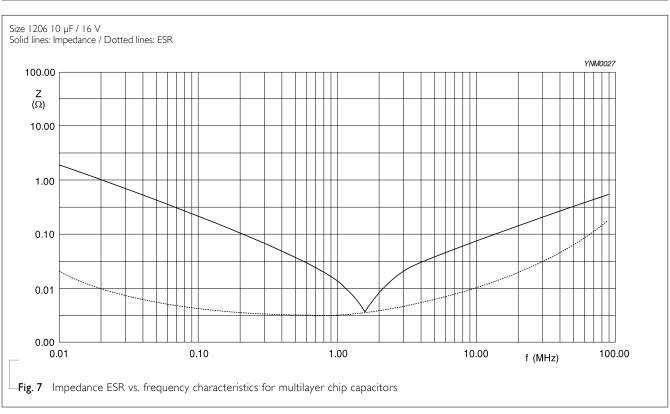
0402 : 22uF 0603 : 47uF



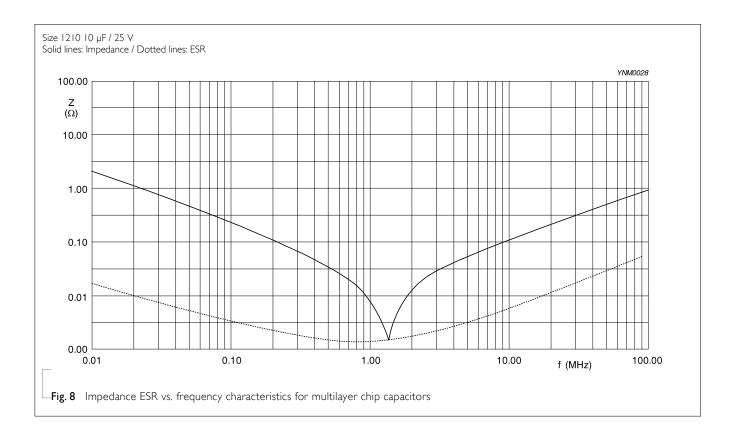








18



SOLDERING RECOMMENDATION

-	Table	7

SOLDERING METHOD	0201	0402	0603	0805	1206	≥ 1210
Reflow	Reflow only	> 100 nF	> IµF	> 2.2 µF	> 2.2 µF	Reflow only
Reflow/Wave		≤ 100 nF	≤IµF	≤ 2.2 µF	≤ 2.2 µF	

TESTS AND REQUIREMENTS

Table 8 Test procedures and requirements

TEST	TEST MET	HOD	PROCEDURE	REQUIREMENTS
Mounting	IEC 60384- 21/22	4.3	The capacitors may be mounted on printed-circuit boards or ceramic substrates	No visible damage
Visual Inspection and Dimension Check		4.4	Any applicable method using × 10 magnification	In accordance with specification
Capacitance (I)		4.5.1	Class 2:	Within specified tolerance
Dissipation Factor (D.F.) ⁽¹⁾		4.5.2	At 20 °C, 24 hrs after annealing Cap \leq I μ F, f = I KHz, measuring at voltage I Vrms at 20 °C Cap > IuF, f = I KHz for C \leq I0 μ F, rated voltage > 6.3 V, measuring at voltage I Vrms at 20 °C f = I KHz, for C \leq I0 μ F, rated voltage \leq 6.3 V, measuring at voltage 0.5 Vrms at 20 °C f = I20 Hz for C > I0 μ F, measuring at voltage 0.5 Vrms at 20 °C	
Insulation Resistance		4.5.3	At U_r (DC) for I minute	In accordance with specification

NOTE

 $I.\ The\ figure\ indicates\ typical\ inspection.\ Please\ refer\ to\ individual\ specifications.$

TEST TEST METHOD PROCEDURE

Temperature Characteristic

4.6 Capacitance shall be measured by the steps shown in the following table.

> The capacitance change should be measured after 5 min at each specified temperature stage.

Step	Temperature(°C)
a	25±2
Ь	Lower temperature±3℃
С	25±2
d	Upper Temperature±2℃
е	25±2

(I) Class I

Temperature Coefficient shall be calculated from the formula as below

Temp, Coefficient =
$$\frac{C2 - C1}{C1 \times \Delta T} \times 10^6 \text{ [ppm/°C]}$$

C1: Capacitance at step c

C2: Capacitance at 125°C

 ΔT : 100°C(=125°C-25°C)

(2) Class II

Capacitance Change shall be calculated from the formula

$$\Delta C = \frac{C2 - C1}{C1} \times 100\%$$

C1: Capacitance at step c

C2: Capacitance at step b or d

Adhesion

4.7 A force applied for 10 seconds to the line joining the terminations and in a plane parallel to the substrate

Force

 Δ C/C

Class2:

size ≥ 0603: 5N size = 0402: 2.5N size = 0201: IN

Bending Strength

IEC 60384-21/22

4.8

Mounting in accordance with IEC 60384-22 paragraph 4.3

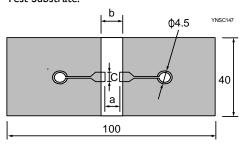
No visible damage

<General purpose series>

<High Capacitance series>

Conditions: bending I mm at a rate of I mm/s, radius jig 5 mm

Test Substrate:



Unit: mm

Class2: X7R: Δ C/C: ±15%

<General purpose series>

Y5V: Δ C/C: 22~-82%

REQUIREMENTS

Δ C/C: ±30ppm

<High Capacitance series>

Class2:

Class I:

 \times 7R/ \times 5R: Δ C/C: \pm 15% Y5V: Δ C/C: 22~-82%

X5R: ±12.5%

X5R: ±10%

	Dimension(mm)			
Туре	a	b	С	
0201	0.3	0.9	0.3	
0402	0.4	1.5	0.5	
0603	1.0	3.0	1.2	
0805	1.2	4.0	1.65	
1206	2.2	5.0	1.65	
1210	2.2	5.0	2.0	

Surface Mount Multilayer Ceramic Capacitors | General Purpose & High Cap. | X5R | 4 V to 50 V

TEST	TEST METH	IOD	PROCEDURE	REQUIREMENTS
Resistance to Soldering Heat		4.9	Precondition: 150 +0/–10 °C for I hour, then keep for 24 ± I hours at room temperature Preheating: for size < 1206: 120 °C to 150 °C for I	Dissolution of the end face plating shall not exceed 25% of the length of the edge concerned
Treat			Preheating: for size ≤ 1206: 120 °C to 150 °C for 1 minute Preheating: for size >1206: 100 °C to 120 °C for 1 minute and 170 °C to 200 °C for 1 minute Solder bath temperature: 260 ±5 °C Dipping time: 10 ±0.5 seconds Recovery time: 24 ±2 hours	 General purpose series> ΔC/C Class2: X5R: ±10% <high capacitance="" series=""></high> ΔC/C Class2: X5R: ±10% D.F. within initial specified value
				R _{ins} within initial specified value
Solderability		4.10	Preheated the temperature of 80 °C to 140 °C and maintained for 30 seconds to 60 seconds.	The solder should cover over 95% of the critical area of each termination
			I. Temperature: 235±5°C / Dipping time: 2 ±0.5 s 2. Temperature: 245±5°C / Dipping time: 3 ±0.5 s	
			(lead free)	
-			Depth of immersion: 10mm	
Rapid Change of	IEC 60384- 21/22	4.11	Preconditioning; 150 +0/ -10 °C for 1 hour, then keep for 24 ± 1 hours at .	No visual damage
Temperature			room temperature	<general purpose="" series=""> ΔC/C</general>
			5 cycles with following detail: 30 minutes at lower category temperature 30 minutes at upper category temperature	Class2: X5R: ±15%
				<high capacitance="" series=""></high>
			Recovery time 24 ±2 hours	Δ C/C
				Class2:
				X5R: ±15%
				D.F. meet initial specified value
				R _{ins} meet initial specified value

whichever is less

4 V to 50 V

TEST TEST METHOD PROCEDURE REQUIREMENTS Damp Heat 1. Preconditioning, class 2 only: No visual damage after recovery with U_r Load 150 + 0/-10 °C /I hour, then keep for 24 ± 1 hour <General purpose series> at room temp $\Delta C/C$ 2. Initial measure: Class2: Spec: refer to initial spec C, D, IR X5R: ±15% 3. Damp heat test: D.F. 500 ± 12 hours at 40 ± 2 °C; Class2: 90 to 95% R.H. I.0 U_r applied X5R: 4. Recovery: ≤ 16V: ≤ 7% or 2 x initial value whichever Class 2: 24 ±2 hours is greater 5, Final measure: C, D, IR \geq 25V: \leq 5% or 2 x initial value whichever is greater P.S. If the capacitance value is less than the minimum R_{ins} value permitted, then after the other measurements Class2: have been made the capacitor shall be preconditioned $X5R: \ge 500 \ M\Omega \ or \ R_{ins} \times C_r \ge 25s$ according to "IEC 60384 4.1" and then the whichever is less requirements shall be met. <High Capacitance series> * General product: 0201 < 100nF Δ C/C 0402 < IuF Class2: 0603 < 2.2uF X5R: ±20% 0805, 1206, 1210 < 4.7uF D.F. Class2: * High cap product: X5R: 2 x initial value max 0201 ≥ 100nF R_{ins} 0402 ≥ IuF Class2: 0603 ≥ 2.2uF 0805, 1206, 1210 ≥ 4.7uF Rins x Cr ≥ 5s

Surface Mount Multilayer Ceramic Capacitors | General Purpose & High Cap. | X5R | 4 V to 50 V

TEST	TEST METHOD	PROCEDURE	REQUIREMENTS
Endurance	IEC 60384- 4.14 21/22	 Preconditioning, class 2 only: 150 +0/-10 °C /I hour, then keep for 24 ±1 hour at 	No visual damage
		room temp	<general purpose="" series=""></general>
		2. Initial measure:	∆C/C
		Spec: refer to initial spec C, D, IR	Class2:
		3. Endurance test:	X5R: ±15%
		Temperature: X5R: 85 °C	D.F.
		Specified stress voltage applied for 1,000 hours:	Class2:
		Applied 2.0 x Ur for general product*.	X5R:
		Applied 1.5 \times Ur for high cap. product*. Applied 1.0 \times Ur for high cap. product*.	≤ 16V: ≤ 7% or 2 × initial value whichever
			is greater
		4. Recovery time: 24 ±2 hours	≥ 25V: ≤ 5% or 2 × initial value whichever
		5. Final measure: C, D, IR	is greater R _{ins}
		P.S. If the capacitance value is less than the minimum	Class2:
		value permitted, then after the other measurements	\times 5R: \geq 1,000 M Ω or R _{ins} \times C _r \geq 50s
		have been made the capacitor shall be preconditioned according to "IEC 60384 4.1" and then the requirements	whichever is less
		shall be met.	<high capacitance="" series=""></high>
		* General product (Applied 2.0 x Ur):	ΔC/C
		0201 < 100nF	Class 2:
		0402 < IuF	X5R: ±20%
		0603 < 2,2uF	D.F.
		0805, I206, I210 < 4.7uF	Class 2:
			X5R: 2 x initial value max
		* High cap product (Applied 1.5 \times Ur):	R _{ins}
		0201 ≥ 100nF	Class 2:
		0402 ≥ I uF	Rins × Cr ≥ 10s
		0603 ≥ 2.2uF	whichever is less
		0805, 1206, 1210 ≥ 4.7uF	
		* High cap product (Applied 1.0 × Ur):	
		0201: 100nF/25V, 2.2uF to 4.7uF	
		0402: 4.7uF to 22uF 0603: 10uF/10V to 25V 22uF to 47uF	
		0805: 10uF/ 25V, 50V, 22uF to 100uF	
		1206: 10uF/ 50V	
Voltage Proof	4.6	Specified stress voltage applied for 1~5 seconds Ur ≤ 100 V: series applied 2.5 Ur	No breakdown or flashover
. 1 001		100 V < Ur ≤ 200 V series applied	
		(1.5 Ur + 100)	
		200 V < Ur ≤ 500 V series applied	
		(1.3 Ur + 100)	
		Ur > 500 V: 1.3 Ur Ur ≥ 1000 V: 1.2 Ur	
		Charge/Discharge current is less than 50 mA	
		S. a. gor Discharge content is 1635 than 50 mil	

Surface Mount Multilayer Ceramic Capacitors | General Purpose & High Cap. | X5R | 4 V to 50 V

REVISION HISTORY

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version 25	Jun. 2, 2017	-	- I.R spec updated
Version 24	Mar. 6, 2017	=	- 0805 L4 spec updated
Version 23	Nov. 15, 2016	=	- Dimension updated
Version 22	Oct. 3, 2016	-	- Dimension and Soldering recommendation updated
Version 21	Jan. 28, 2016	-	- Tests and requirements updated
Version 20	Dec. 04, 2015	-	- Size updated
Version 19	Apr. 09, 2015	-	- Voltage updated
Version 18	Jul. 07, 2014	-	- Voltage updated
Version 17	Mar. 31, 2014	-	- Test condition updated
Version 16	Nov. 29, 2012	-	- Test condition updated
Version 15	Sep. 03, 2012	-	- Test condition updated
Version 14	May 16, 2012	-	- Product range updated
Version 13	May 02, 2012	-	- Product range updated
Version 12	Feb 10, 2012	-	- Product range updated
Version 11	Oct 21, 2011	-	- Product range updated
Version 10	Jun 21, 2011	-	- Product range updated
Version 9	Mar 23, 2011	-	- Product range updated
Version 8	Jan 25, 2011	-	- Rated voltage of 0201 extend to 50V
Version 7	Jan 05, 2011	-	- Product range updated
Version 6	Jul 27, 2010	-	- Dimension on 0603 and 1206 case size updated
Version 5	Apr 21, 2010	-	- The statement of "Halogen free" on the cover added
			- Dimension updated
Version 4	Jan 13, 2010	=	- Thickness updated
Version 3	Aug 17, 2009	-	- Dimension updated
Version 2	Jun 09, 2009	-	- Ordering code updated
Version I	May 15, 2009	=	- Product range updated
Version 0	Apr 15, 2009	-	- New datasheet for general purpose and high capacitance X5R series with RoHS compliant
			- Replace the "6.3V to 50V" part of pdf files: UP-X5R_X7R_HighCaps_6.3-to-25V_II, UY-X5R_X7R_HighCaps_6.3-to-25V_II
			- Combine 0201 from pdf files: UP-NP0X5RX7RY5V_0201_6.3-to-50V_2 and UY-NPOX5RX7RY5V_0201_6.3-to-50V_2
			- Define global part number
			- Description of "Halogen free compliant" added
			- Test method and procedure updated